Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,013	DUPUIS ET AL.	
Examiner	Art Unit	
Leila Malek	2611	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	257	1/14/2008	L.M.		
375	220	1/14/2008	L.M.		
· 375	377 .	1/14/2008	L.M.		
379	350	1/14/2008	L.M.		
379	412	1/14/2008	L.M.		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
·	DATE	EXMR	
EAST	1/14/2008	L.M.	
IEEE	1/14/2008	L.M.	
Consulted M.Ghayour	1/14/2008 [:]	L.M.	
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